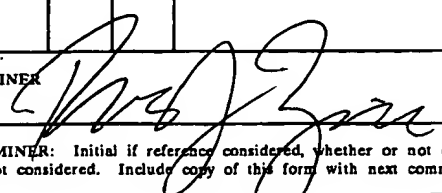
		<b>U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</b>		<b>ATTY. DOCKET NO.</b> MI22-1559		<b>SERIAL NO.</b> 09/810,387	
<b>ART OF ART CITED BY APPLICANT</b> (Use several sheets if necessary)				<b>APPLICANT</b> Craig M. Carpenter et al		<b>FILING DATE</b> March 15, 2001	
				<b>GROUP</b> Unknown		<b>1763</b>	
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AH							
AI							
AJ							
AK							
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Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	
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<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>							
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<b>EXAMINER</b>				<b>DATE CONSIDERED</b>			
				<b>12/15/4</b>			
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		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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